

Layout of the presentation



APC 2004, Vancouver

April 26-28th 2004

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Unit-wide disturbances	6
Challenges of the case study Characterize the disturbances Determine how widespread they are Find the causes Ultimately it all has to be automated 	
Approaches used Spectral and oscillation analysis Wavelet tools from Yamatake and Mitsui Non-linearity analysis (<i>not in the talk</i>) Saturation analysis 	
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